

**Notice of References Cited**

Application/Control No.

10/758,178

Applicant(s)/Patent Under  
Reexamination  
NOZAKI ET AL.

Examiner

ALBERT H. CUTLER

Art Unit

2622

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,774,935	08-2004	Morimoto et al.	348/211.5
*	B	US-6,864,911	03-2005	Zhang et al.	348/42
*	C	US-7,106,364	09-2006	Noro et al.	348/211.3
*	D	US-2004/0201688	10-2004	Wolf et al.	348/207.1
*	E	US-2003/0011683	01-2003	Yamasaki et al.	348/207.1
*	F	US-6,188,431	02-2001	Oie, Masahiro	348/211.5
*	G	US-2003/0071912	04-2003	Minakuti, Jun	348/372
*	H	US-2003/0160870	08-2003	Ziemkowski, Theodore B.	348/207.99
*	I	US-7,046,292	05-2006	Ziemkowski, Ted	348/371
*	J	US-6,670,933	12-2003	Yamazaki, Akihisa	345/1.1
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.